

**Relationship Between Ridge Count and Pattern Intensity Index
In Digital Dermatoglyphics Among the Wancho
Of Arunachal Pradesh, India'**

M.N. Dutta¹, S. Sengupta¹ and P.R. Goral²

- 1. Anthropology Department, Dibrugarh University, Dibrugarh 786 004, Assam, India*
- 2. Anthropological Survey of India, Government of India, Calcutta 700 016, West Bengal, India*

Key words Total and Absolute Finger Ridge Counts. Bisexual Difference. Linear Regression.

ABSTRACT The relationship between pattern intensity index with total finger ridge count and absolute finger ridge counts has been investigated in Wancho, a Mongoloid population of Tirap district, Arunachal Pradesh, India. The results show a stronger linear relationship between pattern intensity index and the absolute finger ridge count than with total finger ridge count.